

Vishay Siliconix

# **Dual N-Channel 20 V (D-S) MOSFET**

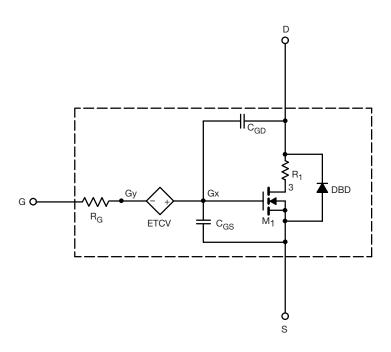
## **DESCRIPTION**

The attached SPICE model describes the typical electrical characteristics of the n-channel vertical DMOS. The subcircuit model is extracted and optimized over the -  $55\,^{\circ}$ C to +  $125\,^{\circ}$ C temperature ranges under the pulsed 0 V to 5 V gate drive. The saturated output impedance is best fit at the gate bias near the threshold voltage. A novel gate-to-drain feedback capacitance network is used to model the gate charge characteristics while avoiding convergence difficulties of the switched  $C_{gd}$  model. All model parameter values are optimized to provide a best fit to the measured electrical data and are not intended as an exact physical interpretation of the device.

## SUBCIRCUIT MODEL SCHEMATIC

## **CHARACTERISTICS**

- N-Channel Vertical DMOS
- Macro Model (Subcircuit Model)
- Level 3 MOS
- Apply for both Linear and Switching Application
- Accurate over the 55 °C to + 125 °C Temperature Range
- Model the Gate Charge, Transient, and Diode Reverse Recovery Characteristics



#### Note

This document is intended as a SPICE modeling guideline and does not constitute a commercial product datasheet. Designers should refer to the appropriate datasheet of the same number for guaranteed specification limits.

# **SPICE Device Model SiB900EDK**

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SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted					
PARAMETER	SYMBOL	TEST CONDITIONS	SIMULATED DATA	MEASURED DATA	UNIT
Static					
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	0.46	-	V
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 1.6 \text{ A}$	0.191	0.183	Ω
		$V_{GS} = 2.5 \text{ V}, I_D = 1.5 \text{ A}$	0.22	0.22	
Forward Transconductancea	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_D = 1.6 \text{ A}$	4.3	3.5	S
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1.3 A	0.82	0.80	V

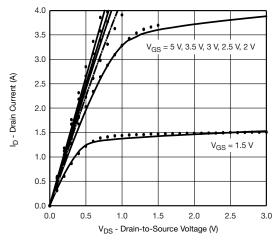
#### Notes

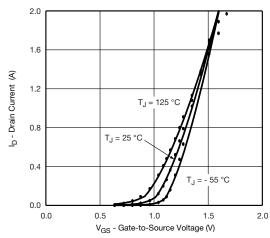
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

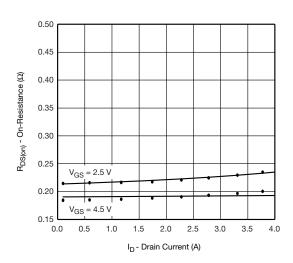


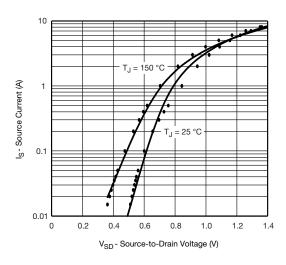
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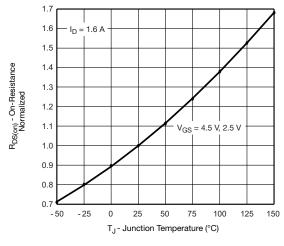
## COMPARISON OF MODEL WITH MEASURED DATA $T_J = 25~{}^{\circ}\text{C}$ , unless otherwise noted

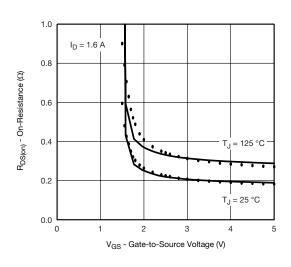












**Note**Dots and squares represent measured data.



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Document Number: 91000 Revision: 18-Jul-08

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